[redacted]

CLASS	SUBCLASS

ISSUE CLASSIFICATION

PATENT NUMBER

/

U.S. UTILITY Patent Application

SCANNED 1st OA Apn

J.P.E. 3

PATENT DATE

APPLICATION NO.	CONT/PRIOR	CLASS	SUBCLASS	ART UNIT	EXAMINER
09/811904	D	250	287	2881	~~Anderson~~ Hashim

APPLICANTS: Richard Torti
Matthew Gwinn
Jerald Dykstra

2/1/4.4

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TITLE: Detector and method for cluster ion beam diagnostics

PTO-2040
12/99

ISSUING CLASSIFICATION

ORIGINAL CLASS	ORIGINAL SUBCLASS	CROSS REFERENCE(S) CLASS	CROSS REFERENCE(S) SUBCLASS (ONE SUBCLASS PER BLOCK)

INTERNATIONAL CLASSIFICATION

☐ Continued on Issue Slip Inside File Jacket

☒ TERMINAL DISCLAIMER

☐ The term of this patent subsequent to _____ (date) has been disclaimed.

☐ The term of this patent shall not extend beyond the expiration date of U.S. Patent No. _____

☐ The terminal _____ months of this patent have been disclaimed.

DRAWINGS Sheets Drwg.	Figs. Drwg.	Print Fig.

_____ (Assistant Examiner) _____ (Date)

_____ (Primary Examiner) _____ (Date)

_____ (Legal Instruments Examiner) _____ (Date)

CLAIMS ALLOWED Total Claims	Print Claim for O.G.

NOTICE OF ALLOWANCE MAILED

ISSUE FEE

Amount Due	Date Paid

ISSUE BATCH NUMBER

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